Notice of References Cited Application/Control No. 10/029,769 Examiner Tan Dean D. Nguyen Applicant(s)/Patent Under Reexamination RILEY ET AL. Art Unit Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,219,648	04-2001	Jones et al.	705/8
*	В	US-6,859,783	02-2005	Cogger et al.	705/10
*	С	US-2001/0047270	11-2001	Gusick et al.	705/1
	D	US-			
	Ε	US-			
	F	US-			
	G	US-			P
	Н	US-			
	-	US-			
	J	US-			
	К	US-			
	٦	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Ν					
	0					
	Р					
	Q					
	R					
	S					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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^{*}A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.